I hereby certify that this correspondence is being deposited with the United States Postal Service via addressed to: Commissioner of Patents and Trademarks, Alexandria, VA 22313, on March 15, 2004. The applicant and/or attorney requests the date of deposit as the filing date. Depositor: Karen Cinq-Mars

Farin ling-man 3/15/04

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of ____:

March 15, 2004

Gregory Freeman, et al.

Group Art Unit: to be assigned

Senal No. 10/708,563

Examiner: to be assigned

Filed: 3/11/04

International Business Machines Corporation

2070 Route 52

Hopewell Junction, NY 12533

TITLE:

STRUCTURE AND METHOD OF FORMING A BIPOLAR TRANSISTOR HAVING A VOID BETWEEN EMITTER AND EXTRINSIC BASE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure set forth in 37 C.F.R. 1.56, and further pursuant to the provisions of 37 C.F.R. 1.97 and 1.98, applicants hereby respectfully submit copies of the non-US patents and publications as listed on Form PTO-1449, attached hereto.

In citing these documents, no representation is made nor intended as to the pertinency or nonpertinency of the art, that better art than that listed is not available, or that other art is not applicable.

No fee is believed to be due for this submission. If any fees are required, however, the Commissioner is hereby authorized to charge such fees to Deposit Account No. 09-0458.

> Respectfully submitted, Gregory Freeman, et al.

H. Daniel Schnumann Registration No. 35,791

Telephone No. 845-894-2481

O 48	MATION DISCLOSURE CITATION	FIS920030255US1	10/708,563
INFO	MATION DISCLOSURE CITATION (Use several sheets if necessary)	Applicant(s) Daniel C. Edelstein, et al.	
MAR 1 7 2004 8	,	Filing Date	Group Art Unit
AEVAMINEDA S		1/6/04	Not Yet Assigned
MADE	OTHER DOCUMENTS (Including Author, T.	itle, Date, Pertinent Pages, Etc.)	
	Jagannathan, et al., "Self-aligned SiGe NPN Transistors with 285 GHz fMAX and 207 GHz fT in a Manufacturable Technology". IEEE Electron Device letters 23, 259 (2002)		
	J.S. Rieh, et al., "SiGe HBTs with Cut-off Freque 771 (2002)	ncy of 350 GHz", International Elec	tron Device Meeting Technical Digest,
	M.W. Xu et al. "Ultra Low Power SiGe:C HBT fo Devices Meeting, 2003.	or 0.18 um RF-FiCMOS, " Proceedin	gs of the IEEE International Electron
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EXAMINER		DATE CONSIDERED	
	il if citation considered, whether or not citation is in conform ude copy of this form with next communication to applicant.		through citation if not in conformance and

Docket Number (Optional)

Application Number 10/708,563